

Search Notes

Application/Control No.

10/053,302

Examiner

Patrick J. Nolan

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

1644

SEARCHED

Class	Subclass	Date	Examiner
updated	previous search	8/2/2005	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated previous search	8/2/2005	PN